AMENDMENTS TO THE CLAIMS:

Please consider the attached clean version of the entire set of claims (pages 14 and 15) by adding claim 1 and line 1 of claim 2, before line 1 of page 14 as follows in the replacement claims commencing on a separate sheet.

What is claimed is:

1. (previously presented) A method of predicting a lifetime of a filament for emitting thermoelectrons in an ion source, the method comprising:

successively measuring a resistance value of the filament during an operation of the ion source on the basis of current flowing through the filament and voltage across the filament; and

predicting the lifetime of the filament till the filament will be broken, on the basis of a rate of change of the resistance value.

- 2. (previously presented) A method of predicting a lifetime of a filament according to claim 1, further comprising:
- computing a time till an application limits of the filament or a time left till the application limits of the filament, on the basis of a rate of change of the resistance value.
- 3. (previously presented) An ion source device comprising:

an ion source having a filament for emitting thermoelectrons;

- a current measuring device for measuring current flowing through the filament;
- a voltage measuring device for measuring voltage across the filament;
- a resistance operation device for computing a resistance value of the filament by using the current and the voltage measured

by the current and voltage measuring devices; and

a prediction operation device for computing a time till an application limits of the filament or a time left till the application limits of the filament, on the basis of a rate of change of the resistance value computed by the resistance operation device.

4. (previously presented) An ion source device according to claim 3, further comprising:

a display device for displaying the time till the application limits of the filament or the time left till the application limits of the filament.

- 5. (previously presented) An ion source device according to claim 3, further comprising:
- a comparing device for comparing the time left till the application limits of the filament with a predetermined reference value, and producing an alarm signal when the time left till the application limits of the filament is smaller than the predetermined reference value.